

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10762814	BAU, DAVID
	Examiner	Art Unit
	Qing Chen	2191

SEARCHED

Class	Subclass	Date	Examiner
717	100,114-123	10/2/2009	/QC/

SEARCH NOTES

Search Notes	Date	Examiner
Updated EAST Search (US-PGPUB; USPAT; USOCR; EPO; JPO; DERVENT; IBM TDB) -- See Search History Printout	10/2/2009	/QC/
717/100,114-123 (limited class search)	10/2/2009	/QC/
Updated EAST Inventor Name Search and Assignee Search (US-PGPUB; USPAT) -- See Search History Printout	10/2/2009	/QC/
NPL Search (ACM; Google; Google Scholar) -- See Printout	10/2/2009	/QC/
Updated PALM Inventor Name Search	10/6/2009	/QC/
Consulted SPE Wei Zhen (AU 2191)	10/5/2009	/QC/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
717	100,114-123	10/6/2009	/QC/